

# Beam Diagnostics for Cyclotrons

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Rudolf Dölling, Paul Scherrer Institut, Villigen-PSI, Switzerland



#### How to spend only 45 minutes on beam diagnostics for cyclotrons?

- option a) take <u>few examples</u> of diagnostics <u>inside a cyclotron</u> (e.g. radial probe, phase probes) discuss it <u>in depth</u>
- option b) give an <u>overview</u> of diagnostics <u>inside a cyclotron</u> discuss operation in different types of cyclotrons/for different applications
- option c) give an <u>overview</u> on diagnostics <u>in general</u> (methods, monitors, tasks) with some <u>weight on cyctrotron & its injection lines</u>

here I follow mostly option c), but

- $\rightarrow$  nearly nothing about details / technical issues / the "art of construction" / electronics
- → just to tell what is around in the field
   (and still this are only examples, many other realizations exist)
- $\rightarrow$  references to literature are given as a starting point
- $\rightarrow$  more slides/information than digestable immediately

 $\rightarrow$  don't try to read everything now

 $\rightarrow$  it is not really a lecture, but I hope you can profit from it



# Beam Diagnostics for Cyclotrons

A) introduction: environment / tasks / beam parameters

B) effects used for transversal profile measurement: basic physics/techniques

- C) diagnostics along the beam path: practical examples mostly from PSI's Injector 2
  - ion source & injection line: matching the beam to cyclotron acceptance
  - injection, central region: beam shaping & current set, betatron oscillation alignment
  - acceleration: adjustment of magnetic field and RF fields
  - extraction: turn separation & efficiency
- D) transversal information (in cyclotron): radial probes (for high/low current)
- E) longitudinal information (in cyclotron): phase probes, bunch shape, ...
- F) <u>beam losses & beam halo</u>: protection / insight



#### beam diagnostics is a very large field

- used at different machines: linear & circular accelerators for electrons, protons, hadrons
- many physical effects are used to sense the beam
- a large variety of technical realisations in many labs

#### beam diagnostics for cyclotrons is a subset

- not all techniques usable due to special boundary conditions
- specific tasks in cyclotrons
- different types of cyclotrons have different needs

#### and well-established

- nearly all principle diagnostic techniques used today were already present in the 1970s
- since then improvement mainly in detail
  - better sensors
  - better electronics (analogue & digital)
  - (better drives)

 $\rightarrow$  improved diagnostics

 $\rightarrow$  adapted diagnostics

(but also improved machines around it)



#### A wealth of literature on beam diagnostics

Proceedings Cyclotron Conferences 1959-..., Beam Diagnostics Conferences BIW 1989-2012, DIPAC 1993-2011, IBIC 2012-..., Accelerator Conferences PAC, EPAC, APAC, IPAC, LINAC, HB  $\rightarrow$  JACoW http://www.jacow.org/ (not all from the beginning)

> (Brandenburg et al. DIPAC03, Dölling DIPAC2005, ...)  $http://accelconf.web.cern.ch/AccelConf/d03/papers/CT10.pdf http://accelconf.web.cern.ch/accelconf/d05/TALKS/ITTA02_TALK.PDF http://accelconf.web.cern.ch/accelconf/d05/TALKS/ITTA02_TALK.PDF http://accelconf.web.cern.ch/accelconf/d05/TALKS/ITTA02_TALK.PDF http://accelconf.web.cern.ch/accelconf/d05/TALKS/ITTA02_TALK.PDF http://accelconf.web.cern.ch/accelconf/d05/TALKS/ITTA02_TALK.PDF http://accelconf.web.cern.ch/accelconf/d05/TALKS/ITTA02_TALK.PDF http://accelconf.web.cern.ch/accelconf/d05/TALKS/ITTA02_TALK.PDF http://accelconf/d05/TALKS/ITTA02_TALK.PDF http://accelconf/d05/TALK$

Journals: Rev. Sci. Instrum., Phys. Rev. ST-AB, Nucl. Instr. Meth. A, JINST, ...

including overviews

JUAS (e. g. Forck 2011) http://www-bd.gsi.de/conf/juas/juas\_script.pdf

CAS (e. g. Wittenburg/Braun/Bravin et al. 2008, 2010)

http://cas.web.cern.ch/cas/France-2008/Lectures/Dourdan-lectures.htm http://cas.web.cern.ch/cas/Bilbao-2011/Lectures/BilbaoLectures.htm

CARE-Conf-08-033-HHH http://adweb.desy.de/mdi/CARE/Bad\_Kreuznach/Reports/ABI-Workshop\_Proceedings\_all.pdf

Wittenburg HB2006, Raich DIPAC2005, Plum BIW04 p. 23, ...

http://accelconf.web.cern.ch/AccelConf/abdwhb06/PAPERS/TUAZ01.PDF http://accelconf.web.cern.ch/AccelConf/d05/TALKS/ITMM01 TALK.PDF

#### and overviews for cyclotrons

Mackenzie CYC78, Clark CYC66, Olivo CYC75, ..... Dölling CYC10

p. 2312

http://accelconf.web.cern.ch/accelconf/c66/papers/a-002.pdf p. 331

http://accelconf.web.cern.ch/accelconf/Cyclotrons2010/talks/wem2cio04\_talk.pdf

#### the field in general





from M.K. Craddock, Lecture "Introduction to Particle Accelerators", see also CYC10 p. 1, http://accelconf.web.cern.ch/accelconf/Cyclotrons2010/talks/mom1cio02\_talk.pdf

#### boundary conditions from different cyclotrons





#### a difficult environment





## JAEA 930 AVF cyclotron

phase probe signal cables damaged by RF after introduction of Flat-Top system of few kV, 80-100 MHz

(now still noise is picked up and hence phase measured with Flat-Top off)

all pictures from S. Kurashima, JAEA





#### a difficult environment





radial view into PSI Ring cyclotron RF on (~3 MW), magnet on (~1.7 T) beam off ~10<sup>-6</sup> mbar



pictures from R. Kan, PSI, see also D. Goetz et al., CYC10, p. 341, http://accelconf.web.cern.ch/accelconf/Cyclotrons2010/talks/wem2cc03\_talk.pdf

thin plasma in sector magnet at lower machine radii (always present?)

impact on
 electrostatic septa
 probe measurements?

for machine safety (prevent the beam from melting something) ms
 e. g. collimator with current measurement
 for machine stabilisation s

e. g. closed loop beam current stabilisation by adjustment of ion source arc current
for machine setup & tuning
1 day ... 1 week

- e. g. phase measurement for adjustment of main coil currentat beam development (finding new settings, with or without changed hardware)
- for error search

A) introduction

- only at **commissioning** 
  - e. g. finding trim-rod settings for centered beam

# for all tasks beam measurements should deliver the $\epsilon$ of information

## which is still needed in spite of

- good design due to theoretical understanding & simulations & field mapping & experience
- suitable operation due to -"-
- good stability of machine components and environment
- reliable machine components

(these fields have improved much over the years, but the demands also increase)

once

1 month



## beam parameters to be determined

beam properties	familiar monitors		
	in beam lines	both	
- current of full beam	- current transformer	- stopper, Faraday-cup	
- transverse position of full beam	- BPM		
- phase of bunch center		- phase probe	
- transverse profile - projection - 2D		<ul><li>wire monitor, harp</li><li>screen</li></ul>	
- transverse emittance - 1D - 2D	<ul><li>- "2 slit" / "3 profile"</li><li>- pepperpot / "4-slit"</li></ul>		
- longitudinal profile		- time structure meas.	
- longitudinal emittance			
- beam ion energy distribution			
- beam losses		- loss monitors	
specific in cyclotrons	in cyclotron		
- turn separation	- radial probes		
- betatron oscillations - amplitudes	(diff., int., viewer,)		
- frequencies	"		
- centering	"		
- precession	"		
- turn number	" / phase probes		
- isochronism, phase history	- phase probes		



7 min

## B) effects used for transversal profile measurement

(depending on geometry also for full beam or beam halo, also part of emittance measurement)

## (effects / methods usable for beam measurements in general)



<i>information</i> 1D: 1D-profile 2D: 2D-profile	configuration	usable effect/device	<i>usabl</i> e A) for machine safety B) permanently	destructive	able to work	alrdy. used inside	usabl. at good	<i>beam current ran</i> ge (assumed DC beam at 70 MeV,	common names
Dz: long. prof. Pos.: position			C) for tuning D) at setup		inside cycl.	cycl.	vacui	10 mm diameter, to be determined	
E: energy C: full current			F) only at commiss.					more precisely)	
		beam self fields			·				
Pos, Dz, C	pickups	comparison of capacitively or inductively coupled RF currents	ABCDE	no	Х	х	Х	nA A	pickup, BPM, phase probe
C, (Dz)	transformer	DC or AC current transformer, wall current monitors	ABCDE	no	?		Х	nA A	DCCT, ACCT, wall curr. m.
1D, C, (Dz)	"wire"	electron (or ion) beam probe	BCDE	no			Х	mA >A	electron beam probe
1D, C	residual gas	residual gas ions (with beam space charge field)	? no				(X)	mA >A	[21]
		direct beam current							
1D (/+Dz), C	in full beam	probe finger: current of stopped beam fraction (/+50 $\Omega$ -readout)	DE	yes	Х	x	Х	nA uA	radial probe/Faraday cup
<1D	beam edge	collimator: -"-	ABCD	"no"	Х	Х	Х	pA mA	collimator
1D, C	wire	wire: -"-	CDE	~no	Х	х	Х	-	wire scanner
		heating of introduced solid matter							
1D, C	in full beam	probe finger: direct (or cooling water) temperature measurement	DE	yes	Х	Х	Х	nA uA	calorimeter probe
<1D	beam edge	collimator: -"-	BCD	"no"	X	Х	Х	nA mA	
1D, C	wire	vibration resonance shift	CDE	~no	- 7		Х	pA uA	vibrating wire scanner
	wire	wire: resistance		~no	X		X	uA mA	(22)
E, U	in full beam	probe linger: 2 thermocouples + degrader		yes	X	~	X	NA MA	[22]
2D, C	In full beam	metal/carbon foil, thermai light emission/thermionic emission		~yes	X	X	X	uA mô	[23, 6]
	WIE	wille	CDE	~110	X	X	X	uA IIIA	
20	in full beam	nanges to introduced solid matter	F	VAS	×	Y		nA uA	foil burn
2D C	in full beam	radiochromic film	F	Ves	X	Ŷ		<na na<="" td=""><td></td></na>	
2D, C	in full beam	foil activation analysis, autoradiograph	F	Ves	X	Ŷ	X	nA uA	autoradiograph
20,0	in lar boarn	secondary particles from introduced solid matter		,00	~			p/1 u/1	aatoraalograph
1D. C	wire	wire: secondary emission current. direct measurement	CDE	~no	х	х	х	pAmA	wire scanner
<1D. C	beam edge	foil: -"-	ABCDE	"no"	X	X	X	pA uA	SEM foil, aperture foil
2D, C	in full beam	foil: secondary emission current + pulling + 2D-electron detector	ABCDE	~no	х		Х	pA uA	· · ·
1D, Dz, C	wire	wire + detection of scattered or secondary particles	CDE	~no	х	х	Х	nA mA	time structure m./wire scanner
Dz, C	in full beam	foil + detection of scattered or secondary particles	CDE	~no	х	х	Х	nA mA	time structure measurement
2D, C	in full beam	scintillating screens + 2D-light detector	CDE	yes	Х	х	Х	pA uA	scintillator screen/viewer probe
1D, Dz, C	"wire"	scintillating fibres + (external) PMT	CDE	~no	Х		Х	<pa na<="" td=""><td></td></pa>	
Dz, C	in full beam	scintillator + (external) PMT	CDE	yes	Х	Х	Х	<pa< td=""><td>time structure measurement</td></pa<>	time structure measurement
<=2D,Dz,E,C	in full beam	silicon/diamond bulk/strip/pixel detector	CDE	yes	Х	Х	Х	<pa <na<="" td=""><td>silicon strip detector</td></pa>	silicon strip detector
		secondary particles from introduced dense gases							
1D, C	"wire"	coaxial ionisation chamber	CDE	~yes	Х		Х	<pa td="" ua<=""><td></td></pa>	
1D, C	in full beam	ionisation chamber + strip-electrode readout (in beam/not)	(B)CDE	yes/~yes	Х		Х	<pa td="" ua<=""><td>strip ionisation chamber</td></pa>	strip ionisation chamber
2D, C	in full beam	ionisation chamber + pixel-electrode readout (in beam)		yes	Х		Х	uA	pixel ionisation chamber
	in full beam	proportional chamber		~yes			X	< <p>&lt;<p>A nA</p></p>	
10, 20, C	in full beam		CDE	yes	X?		Х	<<рА NA	GEM
2D. C		secondary particles from residual or thin gas	ADODE						
20, C 10, C	gas curtain	beam induced illorescence + (external) light detector	ABCDE	~no		~	60	A ≥A	gas curtain BIE monitor
	residual gas	real realized inforescence + (external) light detector	ABCDE	011	X	X	(X)	IIIA 2A	DIF IIIUIIILUI
10 (20), C	residual gas	res, gas ions/electrons with external fields + strip(/+energy) det.	ABUDE	~no	Х	Х		uA A	residual gas profile monitor

Dölling, CYC10 p. 344, http://accelconf.web.cern.ch/accelconf/Cyclotrons2010/papers/wem2cio04.pdf, see also Koziol, CAS2000 p. 154, http://cdsweb.cern.ch/record/425460/files/CERN-2005-004.pdf

B) effects used for transversal profile measurement

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#### temperature measurement









<u>"direct":</u> of stopper block or of cooling water in&outlet (+ flow measurement)

- can be calibrated by ohmic heating
- thermoelements are radiation hard
- small influence of (low energy) stray particles

$$\label{eq:Pin} \begin{split} P_{in} &= wire \; mass \; * \; stopping \; power \; * \; beam \; current \; density \\ [V \; A] \quad [kg] \qquad [V \; m^2/kg] \qquad [A/m^2] \end{split}$$

#### indirect: of wire (or foil)

- vibration resonance shift (very sensitive) Arutunian, BIW08, http://www.als.lbl.gov/biw08/papers-final/MOSTFA01.PDF
- resistance
- light emission (non-linear)
- thermionic emission current (non-linear)

#### wire melting/evaporation? $\rightarrow$ energy balance

Liaw, Cameron, PAC2001, http://accelconf.web.cern.ch/AccelConf/p01/PAPERS/WPAH120.PDF Sapinski, et al., DIPAC09, http://accelconf.web.cern.ch/AccelConf/d09/papers/tupd40.pdf, HB10, http://accelconf.web.cern.ch/AccelConf/HB2010/papers/mopd61.pdf, BIW12, to be published

Example: carbon fibre, diameter 33 um

- 2000 K reached at DC current density
  - 2.3 uA/mm2 for 1 MeV protons

13 10

82 100

- approx. 40x higher current density for flying wire (5 m/s, 10 mm beam diameter)

## direct measurement of <u>current</u> of stopped beam fraction





- stopping material thick enough?  $\rightarrow$  for protons projected range http://physics.nist.gov/PhysRefData/Star/Text/PSTAR.html  $\rightarrow$  for ions e. g. http://www.srim.org, http://geant4.cern.ch
- signal altered by secondary electron emission at surface, SE energy mostly around 2 eV, yield >1 at low beam energies for absolute measurements: suppression with electrode at ~100 V (electrode not to be hit by beam!) or with permanent magnets → Faraday cup

for most applications: better to let SE escape or to pull them away

- signal altered by stray particles (residual gas ions, external SE)
- with magnetic fields & beam space charge  $\rightarrow$  path of SE or stray particles difficult to predict (ExB-drift, ...)
- if directly water cooled: at very small currents measurement can be disturbed by water conduction

#### secondary emission current, direct measurement





- at higher energies: ions not stopped, signal only from SE
- SE-yield depends on surface material & structure & contamination, ion species & energy
- SE-yield depends on irradiation history, Titanium is good Ferioli, Jung, DIPAC97, pp. 168-170
- signal is very fast (<ps) and linear (large dynamic range)

- optional pulling of SE by external electrodes or adjacent foils (foils also block stray particles, filtering of high voltage needed)



#### secondary emission current, 2D-measurement



according to Badano et al., DIPAC03/07 http://accelconf.web.cern.ch/AccelConf/d03/papers/CT09.pdf http://accelconf.web.cern.ch/AccelConf/d07/papers/wepc20.pdf

- ~non-destructive
- fast
- sensitive
- fragile foil?  $\rightarrow$  careful venting of beam line

#### other variants:

Kruglov et al., Nuclear Instruments and Methods in Physics Research A 441 (2000) 595-604 Shapira et al., Nuclear Instruments and Methods in Physics Research A 454 (2000) 409-420

very fast: http://accelconf.web.cern.ch/accelconf/HB2010/talks/weo2a02\_talk.pdf PAUL SCHERRER INSTITUT

### detection of scattered or secondary particles





- scattering at high and low energies
  (at not too low energies ~according to Rutherford formula)
- creation of secondaries at higher energies
- very large dynamic range (if background radiation low, coincidence technique)



scintillating screens & fibres



instead of moving wire or grid



- light emission spectrum (to be compatible with light detector)
- decay time ns .... >s
- doped bulk anorganic material (ceramic, glass, crystal → rugged) doped plastics thin coating on metal (phospor powders → fragile) thin layer in plastic (intensifying screens, Kodak Lanex = P43)
- image broadening by light scattering  $\rightarrow$  thin screen
- saturation, thermal damage, radiation hardness
  - $\rightarrow$  for limited beam current

http://cas.web.cern.ch/cas/France-2008/Lectures/Bravin.pdf Jung et al., DIPAC03, http://accelconf.web.cern.ch/AccelConf/d03/papers/IT03.pdf Gütlich et al., DIPAC09, http://accelconf.web.cern.ch/AccelConf/d09/papers/tupb04.pdf DIPAC11, http://accelconf.web.cern.ch/AccelConf/DIPAC2011/papers/mopd57.pdf http://accelconf.web.cern.ch/AccelConf/DIPAC2011/papers/mopd53.pdf Re et al. PAC2005, http://accelconf.web.cern.ch/AccelConf/p05/PAPERS/RPAT002.PDF

B) effects used for transversal profile measurement



http://www.proxitronic.de/datasheets/20091001\_ebv.pdf

Туре	Composition	Light Emission				Decay Time		
		Range		Maximum	Color	Decay of Light Intensity		
		from	to	typically at		from 90 % to 10 % in	from 10 % to 1 % in	
P 43	Gd <sub>2</sub> O <sub>2</sub> S:Tb	360 nm	680 nm	545 nm	green	1 ms	1,6 ms	
P 46	Y <sub>3</sub> Al <sub>5</sub> O <sub>12</sub> :Ce	490 nm	620 nm	530 nm	yellow green	300 ns	90 µs	
P 47	Y₂SiO₅:Ce,Tb	370 nm	480 nm	400 nm	blue white	100 ns	2,9 µs	

#### effects on foils & films



#### paper/Kapton foil coloration

- colouring by beam heating
- readout with scanner
- not linear

#### radiographic film

- like photographic film
- development needed

#### track-etch foil

- tracks in nitrocellulose
- etched
- counted

#### radiochromic film

- optical density increases with dose
- dose range 0.001 ... 100 Gy
- easy to use (no light sensitivity, no development)
- readout with flatbed scanner
- can be calibrated

#### http://www.gafchromic.com/

Mumot et al., PTCOG46, http://ptcog.web.psi.ch/PTCOG46/May%2022,%202007,%20mor ning/(22)-(5.22)(9.00)M.Mumot(Dose%20distribution%20measur ements).pdf

Optical Density - Dose Calibration Curve for a Gafchromic EBT film (lot # 36076-002l) iradiated with protons



Bues, PTCOG45, http://online1.ispcorp.com/\_layouts/Gafchromic/content/presentech/pdf/14MBues.pdf

#### foil activation

- activation of metal or polyethylene foil (if ion energy above a few MeV)
- contact radiography to
- a) imaging plate (semistable excitation) read-out with laser scanner (deexcitation observed with PMT)
  - few  $\mu Sv/h$  detectable, 50  $\mu m$  resolution
  - $\rightarrow$  very large dynamic range
- b) radiochromic film
  → large dynamic range

#### - linear

Clarke et al., NIM A 585 (2008) 117–120 Tamburella, Giles, NIM B 266 (2008) 4678-81



Avila-Rodriguez et al., Applied Radiation and Isotopes 67 (2009) 2025-2028

Rudolf Dölling, Beam Diagnostics for Cyclotrons, ECPM2012 20



## proportional chamber





- signal additionally enhanced by electron avalanche amplification by ~ $10^4$
- amplification dependent on beam current density  $\rightarrow$  non-linear
- gas flow needed



front: ionisation chamber gas, e. g. Ar (70%)  $CO_2$  (30%) middle: 1-3 GEM foils rear: strip pattern 1D or 2x 1D or pixels



electron avalanche in high electric field in holes





- signal additionally enhanced by electron avalanche by  $10^2 - 10^5$  depending of number of GEMs



- less discharges with more GEMs
- amplification not dependent on beam current density
- $\rightarrow$  linear (at not too high current densities)
- radiation hard
- gas flow needed

pictures from Gas Detectors Development Group, CERN, http://gdd.web.cern.ch/GDD/

#### beam induced fluorescence (BIF)





The first external cyclotron beam, obtained on March 26, 1936. The glow arises from the ionization of the air by the 5.8 MeV deuterons. http://imglib.lbl.gov/LBNL\_Res\_Revs/RR\_online/81F/81fc hp2.html

in air: deuterons stopped after half a meter

in residual gas: distance earth – moon (i. e. non-destructive) very faint glow



B) effects used for transversal profile measurement

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#### residual gas ions (with external fields)





- profile broadened by beam space charge (improved by vertical magnetic field & detecting electrons)

- non-destructive but eventual beam space charge neutralisation disturbed by external electric field
- sensitive

Kamerdzhiev, DIPAC09, http://accelconf.web.cern.ch/AccelConf/d09/papers/tupb12.pdf DeLuca, PAC69, http://accelconf.web.cern.ch/AccelConf/p69/PDF/PAC1969\_0813.PDF

#### residual gas ions (with beam space charge field)





B) effects used for transversal profile measurement

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Shestak et al., Triumf Design Note TRI-DN-87-36 (1987) Prabir et al., Rev. Sci. Instrum. 76 (2005) 023301 and many others

- beam space charge potential deflects transversal electron beam
- deflection depending on impact parameter is measured
- analytical solution for charge density distribution of round beams (Abel inversion) Stallings, J. Appl. Phys. 42 (1971) 2831
- a positive beam potential depth of at least a few V is required
- non-destructive
- charging of surfaces and stray magnetic fields can be problematic
  - → higher electron energy (→ less sensitivity) e. g. 75 keV Aleksandrov et al., DIPAC09, http://accelconf.web.cern.ch/AccelConf/d09/papers/tuoa03.pdf

→ ions Bosser et al., CERN/PS 2000-071, http://cdsweb.cern.ch/record/478698/files/ps-2000-071.ps.gz



#### 18 min

## C) diagnostics along the beam path

## most examples from PSI's high power proton facility





which operates  $\sim 4800$  h/a for  $\sim 400$  users/a



C) diagnostics along the beam path

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ion source & injection line:

matching the beam core to the cyclotron acceptance

#### beam position, profile, current





C) diagnostics along the beam path: injection line (matching the beam core to the cyclotron acceptance)

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#### calorimetric slit scanner (at 60 keV, destructive)



- internal cooled copper block behind vertical slit
- measurement of water in-/outlet temperatures





## profile monitors

wire scanner (870 keV 11 mA up to 20% DC)



beam induced fluorescence monitor (870 keV full beam non-destructive)

Rezzonico, CYC87 p. 457







C) diagnostics along the beam path: injection line (matching the beam core to the cyclotron acceptance)

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#### calorimetric slit scanner (at 60 keV, destructive)



- internal cooled copper block behind vertical slit
- measurement of water in-/outlet temperatures





profile monitors

-20

-20

-20

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- 10

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- 10

MWL Profile Plot 16 - 09

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MWL06

MWL04

MWL02

Makana http://www.

10

10

10

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20

20

20

20

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20





beam induced fluorescence monitor (870 keV full beam non-destructive)

#### PMT and lens scanned



C) diagnostics along the beam path: injection line (matching the beam core to the cyclotron acceptance)

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### emittance from many profiles + Transport fit



- input: magnet currents & beam width from profile monitors

- enveloppe fit (over-determined) by "simple" Transport calculation (matrices) including linear space charge  $\rightarrow$  emittance



C) diagnostics along the beam path: injection line (matching the beam core to the cyclotron acceptance)

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direct emittance measurement

- destructive, limited in beam power & energy

moving slit + grid



 $http://adweb.desy.de/mdi/CARE/Bad\_Kreuznach/Reports/ABI-Workshop\_Proceedings\_all.pdf$ 

profile based emittance measurement

- input only 3 beam widths  $\rightarrow$  less information



needs "beam gymnastics"  $\rightarrow$  difficult for high power beams

C) diagnostics along the beam path: injection line (matching the beam core to the cyclotron acceptance)

PAUL SCHERRER INSTITUT
test stand simulates cyclotron center with internal source including magnetic field and fixed puller voltage/geometry:

## emittance of internal ion source [MSU]



Measurement of radial emittance

numerical simulation for different plasma pressures:

#### block: 5% max red: 25% max blue: 50% max green: 75% max 50 mA 20 curved (mrad) 90.2% emittance plasma 26.8 mm-mroc 0 Chimney meniscus 0.248 mm\_mrov ర్ inward -20 **52** μA beam Puller. -40low 40 Wire Probe 250 mA arc 20 (mrad) Slit Probe 90.4% emittance 25.6 mm-mra 0 normalized emittana 0.237 mm-mra ຮັ beam **165** μA -20 -40 0 0 straight 350 mA arc 20 slit – wire emittance measurement medium (mrad) 90.3% emittance 23.0 mm-mra 0 for radial emittance: 0.212 mm-mrod ຮ້ -20 beam **195** μA source 450 mA arc 20 beam (mrad) 90.1% emittance befor 24.3 mm-mra 0 slit ormalized emittana 0.224 mm-mro outward ຮັ wire -20 beam 227 μA slit beam after high -40 blocked beam slit -3 all figures from E. R. Forringer, Dissertation 2004, MSU (similar for axial emittance) http://www.nscl.msu.edu/ourlab/publications/download/Forringer 2004\_199.pdf

C) diagnostics along the beam path: injection line (matching the beam core to the cyclotron acceptance)

collimators with current readout





- protect the machine by interlock generation
- shape the beam (this may need cooling)



C) diagnostics along the beam path: injection line (matching the beam core to the cyclotron acceptance)



injection, central region

beam shaping & betatron oscillation alignment

### current set & beam shaping



- by cutting into beam with movable cooled <u>collimators with current measurement</u> (no activation below a few MeV)
- (current set combined with phase selection, dominates "injection efficiency, ~13 kW)
- again: collimators help to "guide" the beam and to protect the machine
- -stopper allows to set up central region alone at full current (~10 kW)



#### Injector 2 central region

horizontal adjustment (collimator, trim coil, movable inflector dipole)

vertical adjustment (collimator, deflector, inflector dipole)

horizontal collimator (with current measur.)

vertical collimator (with current measur.)

diff.-integral probe phase probe

stopper (with current measur.)





### beam centering & betatron oscillation alignment

- beam "positions" at full current: known only from <u>collimator currents</u>, at low current: from <u>radial probe</u>
- vertical centering with vertical adjustments
- horizontal betatron oscillations around the centered path adjusted with horizontal adjustments





acceleration:

adjustment of magnetic field and RF fields













# extraction:

turn separation & efficiency



C) diagnostics along the beam path: extraction (turn separation & efficiency)



C) diagnostics along the beam path: extraction (turn separation & efficiency)

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C) diagnostics along the beam path: extraction (turn separation & efficiency)



29 min

D) transversal information (in cyclotron): radial probes at high / low current

# radial probes: types and uses



- radial: integral (thick) or differential
- axial: segmentation / tomography

## schematic

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radial probes: types and uses

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from Rao et al., TRI-DN-04-8, http://legacyweb.triumf.ca/publications/pub/dn/2004/TRI-DN-04-08.pdf

see also Schreuder, NIM 95 (1971) p. 237



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Figure 11: Measured beam currents on LE1 and LE2 vs the radial position of LE1, with LE2 parked at defferent radii. Shown on the top are the beam distributions along the radius. The data at  $\sim 69$  inch clearly shows that beam hitting LE2 is coming from 2 turns.

#### D) transversal information: radial probes



D) transversal information: radial probes

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# radial probes: types and uses / signal





D) transversal information: radial probes

simulation

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radial probes: signal







radial probes: high current





thermal limits at high current

size limitation → power limitation ~15 kW protons power input maximal if beam particle just stopped

→ difficult at low energies (few MeV) and heavier beam particles

thin carbon fibres have highest performance but give small electrical signal

alternatives?



#### residual gas ion monitor



The layout inside the vacuum chamber of SPC1. Components that can be seen are the first slit system, electrostatic- and first magnetic channel, ion source (slightly withdrawn) and, to the left of the dee in the foreground, the ionisation beam profile monitor.



iTHEMBA Injector SPC1, du Toit et al., CYC86 p. 109



signal level OK at 10<sup>-6</sup> mbar (amplification by e.g. MCP not needed)

dynamic range?

- probably determined by stray particles
- probably <1000

(later abandoned due to isolation problems from sputtering in machine center)

### beam induced fluorescence





# 32 channel PMT





http://accelconf.web.cern.ch/accelconf/e08/papers/tupc022.pdf

#### all used in beam lines

(less signal than RGI)
dynamic range? determined by stray light at best ~500

# in the cyclotron?

- disturbing light
- radiation hard & sensitive camera?
- or relay optic
- PMT/MCP magnetic shielding?



#### screens

## viewer probe



Figure 1. Sketch showing the head of the TV probe. The angle the beam makes with the scintillating plate changes between 35 and 65 degrees.

MSU, Marti et al., CYC92 p. 435

### also (since long): with external observation

# foil based methods



#### thin paper burn



IBA, Kleeven, CYC01, http://accelconf.web.cern.ch/accelconf/c01/cyc2001/paper/L-1.pdf Figure 12: Beam spots in the central region

also (for commissioning): Kapton, Mylar, stainless steel track-etch foil radiochromic film radiographic film foil activation radiography



# 36 min

# E) longitudinal information (in cyclotron)

# Garren & Smith detuning

(usually resonance curve shown at fixed radius, main field varied)



#### integral probe head radius

Garren & Smith,

CYC63, http://accelconf.web.cern.ch/accelconf/c63/papers/cyc63a03.pdf

Ch1

can deliver local phase width around center phase

E) longitudinal information

# phase probes



#### here: at multi-head radial probe (usually: fixed pickups)



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integral probe current





#### silicon detector placed directly in very low current beam

#### silicon detector on radial probe (shield removed)



#### probe head with shield & preamplifier





#### can deliver

- time structure (moderate resolution)
- beam particle energy spectrum (thick detector)
- beam particle stopping power (thin detector)



#### cyclotron separates different particles by q/m

#### time-structure shows separation (radius varied)





based on scattered protons:

- measure longitudinal and radial density distributions of the beam bunches (averaging over many bunches)
- arrival time of scattered protons compared to RF reference (discriminator & Time-to-Ampl. Converter & Multi-Channel-Analyzer)
- resolution incl. electronics ~31 ps fwhm
   (determined from correlation between detectors A, B)

D"olling, HB10, http://accelconf.web.cern.ch/accelconf/HB2010/papers/mopd62.pdf



(much faster with RF-deflection of secondary electrons from biased wire) Feschenko et al., LINAC86, p. 323

Feschenko et al. PAC01, http://accelconf.web.cern.ch/AccelConf/e90/PDF/EPAC1990\_0750.PDF Bylinsky et al., EPAC94, http://accelconf.web.cern.ch/AccelConf/e94/PDF/EPAC1994\_1702.PDF Feschenko et al., PAC07, http://accelconf.web.cern.ch/AccelConf/p07/PAPERS/THOAAB01.PDF Aleksandrov et al., BIW12, MOPE041



bunch shape detector (high beam current)



2.3 mA proton beam, moving bunches as seen from above  $\rightarrow$  detailed input to beam dynamic simulations



E) longitudinal information

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40 min

# F) beam losses & beam halo

beam losses: "protection aspect"

- activation
- melting of cyclotron components by missteered (high power) beam
  - $\rightarrow$  fast interlock generation needed (~1 ms)

#### <u>collimators</u>

injection into Ring cyclotron: collimator and coil support destroyed

(defect of high level interlock module)





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beam losses: "protection aspect"

#### ionization chambers

- most simple variant: ambient air filled, 300 V
- useful at beam energies >40 MeV  $\rightarrow$  proton range in steel > 3 mm
- placed ~0.1...1 m from beam, fixed position for reproducibility
  approximate calibration by steering low current beam into wall



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beam losses: "protection aspect"

- radiation induced attenuation of optical fibers (range few kGy, position resolution ~1 m) Wulf, Körfer, DIPAC09, http://accelconf.web.cern.ch/AccelConf/d09/papers/weoa01.pdf



http://tesla.desy.de/~lfroehli/download/ERL\_instrumentation\_ws\_2008\_BLMs.pdf see also Wittenburg, CAS2008, http://cas.web.cern.ch/cas/France-2008/Lectures/Wittenburg-BLM.pdf

F) beam losses and beam halo


## beam losses & beam halo: "knowledge aspect"



"empirical tuning" has its limits:

- losses lead to activation, this limits the beam current (personal dose at maintenance)
- to prevent losses, the beam halo must be cut or matched through all the machine (some controlled loss in shielded locations allowed)
- it is difficult to measure and simulate the beam halo (new halo by scattering at collimators, ...)
- hence empirical tuning is used ("turn all available knobs") based on <u>collimator/loss monitor readings</u>
- -,,knowledge aspect" diagnostics only needed at trouble (,,what is different than yesterday?")

# $\rightarrow$

- delivers optimum for given machine configuration
- cannot suggest changes of machine configuration for improvement
- difficult to find hidden causes in case of persistantly bad beam quality
- → detailed beam dynamic simulations needed for progress (,,a real understanding of losses")



### beam losses & beam halo: "knowledge aspect"

### detailed numerical simulations

- including beam halo, scattering at collimators, 3D-poisson solver, space charge neutralisation
- lead to a better understanding of the losses: where (at low energies) to cut and how to match the halo
- a very high dynamic range is needed: every 10 nA of beam losses are important
- fitting capabilities needed in order to find the best fit to a large set of detailed profile & loss data (detailed information on quality/error has to be provided with each measurement)
- very encouraging work is in progress:



simulation of turn-pattern at exit of Ring cyclotron



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Bi et al., CYC10, http://accelconf.web.cern.ch/accelconf/Cyclotrons2010/papers/mopcp045.pdf

beam losses & beam halo: "knowledge aspect"



### input from beam diagnostics to detailed simulations of beam losses

- losses are measured with large dynamic range
  - at collimators (limited by stray particles)
  - with loss monitors
- transverse and longitudinal profiles (1D, 2D)
- emittance (2D, 4D)

but spatial resolution is usually modest

accuracy and dynamic range have limits

actually it is not really clear what the requirements to precision/resolution/dynamic range of measurements are in this context

(requirements need to be evaluated by simulations)

# are "future losses" visible in in a projected 1D profile?

- at a high current beam (2 mA) a relevant loss (~10 nA) is a beam fraction of 5e-6
- in a projected 1D profile (e.g. from a wire scanner) a dynamic range of ~1e6 is needed to see the 10 nA compared to the 2 mA (of cause the loss particles are only visible if located in the halo and not in the beam core)
- <u>in beam lines</u> (low background & stray particles) this is feasible for wire scanners using detection of scattered particles and maybe even with direct wire current measurement
- example of purposely caused losses with known origin, which change the beam profile:

Detection of beam ions, scattered ~20 m upstream by a 33 um carbon fibre placed in the beam, with two vertical wire scanners in front of the Ring cyclotron. The beam losses in Ring cyclotron are increased by the order of 100 nA. (This is qualitative because the logarithmic current amplifiers are too slow compared to wire speed at currents below a 3e-4 level.)

(we need to improve this by a factor of 10 to 100)

<u>in the cyclotrons</u> this is much more difficult (high background & stray particles)

 $\rightarrow$  separate measurement of beam core and halo

F) beam losses and beam halo

ent of beam core and halo









44 min

# Thanks for listening!

### beam current and its noise

Action

2.0

1e02

8.0

4.0

2.0 1e01 8.0

> 6.0 4.0

2.0

0.0

0.2

0.4 0.6

0.8

1.0 1.2

4 sigma/average

12 microsecond averages sampled at 5 kHz

12% @

0

0

**6**%

3%

1% @

5000 Hz

1250 Hz

312 Hz

78 Hz

4 sigma / average plot



Mon Oct 26 16:54:55 CET 2009

Avg 145.0 nA

Min 132.0 nA Max 159.3 nA

@ 5 kHz

• Log

2.4

 $x10^{2}$ 

averaging of

4<sup>n</sup> samples

noise decreases

by factor of 2<sup>n</sup>

 $\rightarrow$  stochastic noise

1.4

1.6

1.8 2.0 2.2

### at high currents:

### - DC/AC current transformers

Denard, CAS2008, http://cas.web.cern.ch/cas/France-2008/Lectures/Denard.pdf Webber, Proc. AccApp'07 p. 145-151

- resonant cavity Reimann, Rüede, NIM 129 (1975) 53-58

at low currents:

- Cryogenic Current Comparator Vodel et al., DIPAC2007, http://accelconf.web.cern.ch/AccelConf/d07/papers/wepb30.pdf
- thin SEMs or ionisation chambers (scattering!)

### example:

ionisation chamber behind PSIs medical cyclotron Dölling et al., Proc. AccApp'07 p. 152-159

#### measures current fluctuations from the internal ion source Schippers et al., CYC07, http://accelconf.web.cern.ch/AccelConf/c07/PAPERS/300.PDF



### beam current and its noise



Dölling et al., Proc. AccApp'07 p. 152-159





thin SEM or ionisation chamber behind PSIs medical cyclotron

used for proton beam 250 MeV

- IC: in a  $N_2$  filled box with thin Ti-windows signal amplified by 43 thermal limit: 1  $\mu$ A beam
- SEM: in vacuum signal "amplified" by 0.053 microphonics